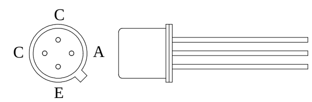
K120P

Optocoupler with Phototransistor Output

Description

The K120P consists of a phototransistor optically coupled to a gallium arsenide infrared emitting diode in a hermetically sealed 4 lead TO72 metal can package for high reliability requirements.



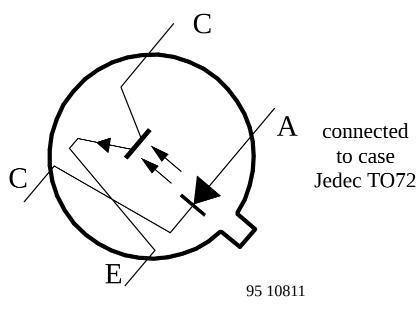
Applications

Galvanically separated circuits.

Features

- Hermetically sealed case
- High isolation resistance
- DC isolation test voltage V_{IO} = 1000 V
- **C**urrent **T**ransfer **R**atio, (CTR) typical 50 %
- Coupling capacitance typical 1.5 pF
- Low temperature coefficient of CTR
- Large ambient temperature range

Pin Connection



Absolute Maximum Ratings

Input (Emitter)

Parameters	Test Conditions	Symbol	Value	Unit
Reserve voltage		V_R	7	V
Forward current		I_F	60	mA
Forward surge current	t ≤ 10 μs	I_{FSM}	1.5	A
Power dissipation	$T_{amb} \leq 25°C$	P_V	100	mW
Junction temperature		T_j	125	°C

Output (Detector)

Parameters	Test Conditions	Symbol	Value	Unit
Collector-emitter voltage		V_{CEO}	35	V
Emitter-collector voltage		V_{ECO}	7	V
Collector current		I_C	100	mA
Power dissipation	$T_{amb} \leq 25°C$	P_V	200	mW
Junction temperature		T_j	125	°C

Coupler

Parameters	Test Conditions	Symbol	Value	Unit
DC isolation test voltage		V_{IO} 1)	1000	V
Power dissipation	$T_{amb} \leq 25°C$	P_{tot}	300	mW
Ambient temperature range		T_{amb}	–55 to +100	°C
Storage temperature range		T_{stg}	–55 to +125	°C
Soldering temperature	2 mm from case, t ≤ 10 s	T_{sd}	260	°C

Electrical Characteristics

T_{amb} = 25°C

Input (Emitter)

Parameters	Test Conditions	Symbol	Min.	Typ.	Max.	Unit
Forward voltage	I_F = 50 mA	V_F		1.25	1.5	V
Reserve voltage	I_R = 100 μA	$V_{(BR)}$	7			V
Junction capacitance	V_R = 0, f = 1 MHz	C_j		50		pF
Reserve current	V_R = 3 V	I_R		0.35	10	μA

Output (Detector)

Parameters	Test Conditions	Symbol	Min.	Typ.	Max.	Unit
Collector-emitter breakdown voltage	I_C = 1 mA	$V_{(BR)CEO}$	35			V
Emitter-collector breakdown voltage	I_E = 100 μA	$V_{(BR)ECO}$	7			V
Collector dark current	V_{CE} = 20 V, I_F = 0, E = 0	I_{CEO}			50	nA

Coupler

Parameters	Test Conditions	Symbol	Min.	Typ.	Max.	Unit
DC isolation test voltage	t = 1 min	V_{IO} [1)]	1000			V
Isolation resistance	V_{IO} = 1 kV, 40% relative humidity	R_{IO} [1)]	10^{10}	10^{12}		Ω
I_C/I_F	V_{CE} = 5 V, I_F = 10 mA	CTR	0.25	0.50		
Collector emitter saturation voltage	I_F = 20 mA, I_C = 2.5 mA I_F = 10 mA, I_C = 0.5 mA	V_{CEsat} V_{CEsat}		 0.1	0.3 	V V
Cut-off frequency	V_{CE} = 5 V, I_F = 10 mA, R_L = 100 Ω	f_g		110		kHz
Coupling capacitance	f = 1 MHz	C_k		1.5		pF

1) related to standard climate 23/50 DIN 50 014

Switching Characteristics

V_S = 5 V

Type	R_L = 100 Ω, see figure 1							R_L = 1 kΩ, see figure 2		
	t_d[µs]	t_r[µs]	t_{on}[µs]	t_s[µs]	t_f[µs]	t_{off}[µs]	I_C[mA]	t_{on}[µs]	t_{off}[µs]	I_F[mA]
K120P			5.0			3	5	11	13.8	20

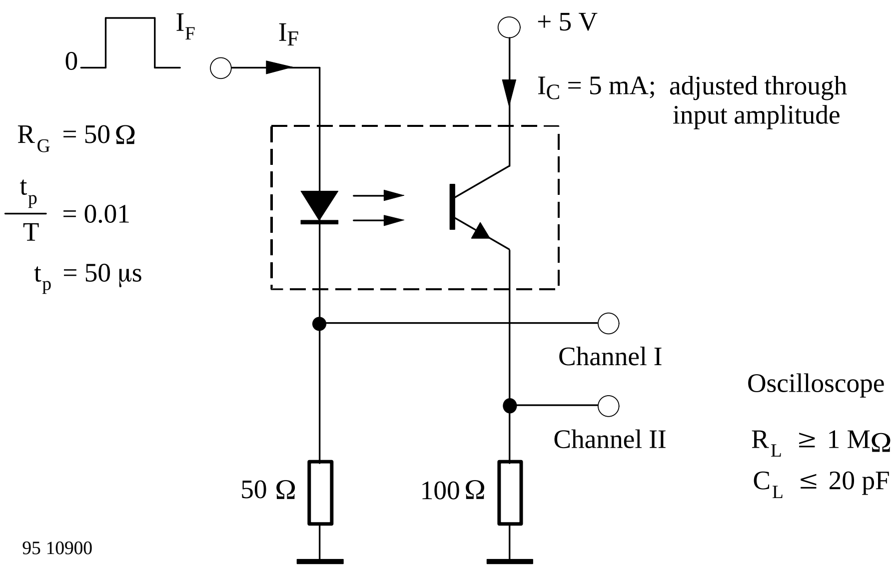


Figure 1. Test circuit, non-saturated operation

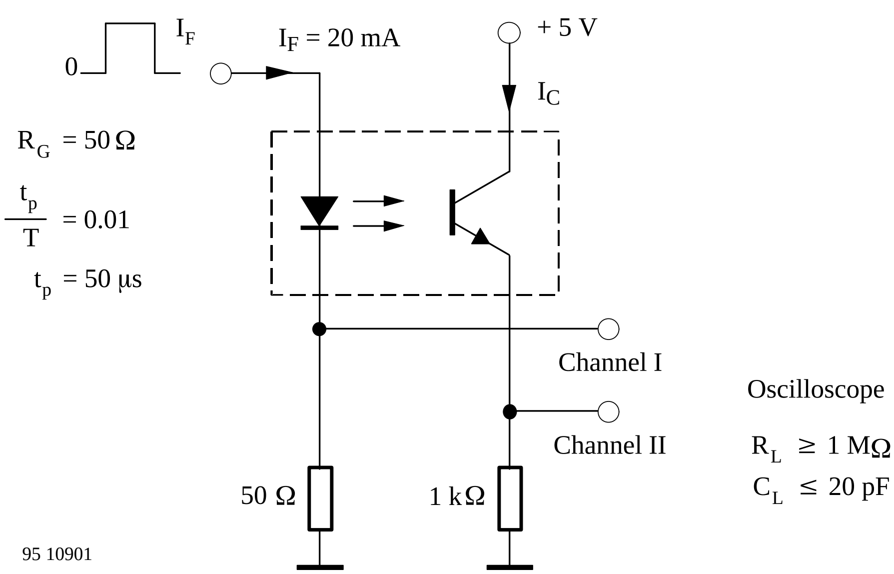


Figure 2. Test circuit, saturated operation

Ozone Depleting Substances Policy Statement

It is the policy of **TEMIC TELEFUNKEN microelectronic GmbH** to

1. Meet all present and future national and international statutory requirements.

2. Regularly and continuously improve the performance of our products, processes, distribution and operating systems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) intend to severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

TEMIC TELEFUNKEN microelectronic GmbH semiconductor division has been able to use its policy of continuous improvements to eliminate the use of ODSs listed in the following documents.

1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively

2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA

3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

TEMIC can certify that our semiconductors are not manufactured with ozone depleting substances and do not contain such substances.

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